

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1819 is a switching device that can be driven directly by a 4.0 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power management of notebook computers and so on.

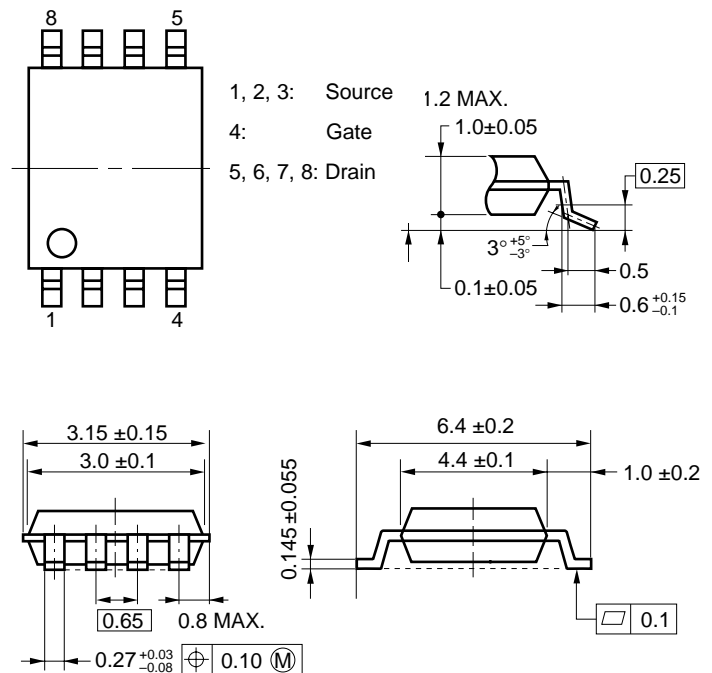
FEATURES

- 4.0 V drive available
- Low on-state resistance
 - $R_{DS(on)1} = 12 \text{ m}\Omega \text{ MAX. (} V_{GS} = -10 \text{ V, } I_D = -6.0 \text{ A)}$
 - $R_{DS(on)2} = 18.5 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.5 \text{ V, } I_D = -6.0 \text{ A)}$
 - $R_{DS(on)3} = 22 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.0 \text{ V, } I_D = -6.0 \text{ A)}$
- Built-in G-S protection diode against ESD

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|--------------------|--------------|
| μ PA1819GR-9JG | Power TSSOP8 |

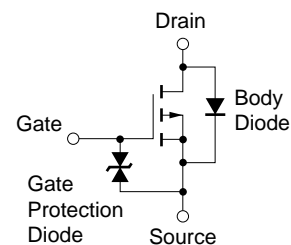
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

| | | | |
|--|----------------|-------------|------------------|
| Drain to Source Voltage ($V_{GS} = 0 \text{ V}$) | V_{bss} | -30 | V |
| Gate to Source Voltage ($V_{DS} = 0 \text{ V}$) | V_{GSS} | ± 20 | V |
| Drain Current (DC) ($T_A = 25^\circ\text{C}$) | $I_{D(DC)}$ | ± 12 | A |
| Drain Current (pulse) ^{Note1} | $I_{D(pulse)}$ | ± 48 | A |
| Total Power Dissipation ^{Note2} | P_T | 2.0 | W |
| Channel Temperature | T_{ch} | 150 | $^\circ\text{C}$ |
| Storage Temperature | T_{stg} | -55 to +150 | $^\circ\text{C}$ |

EQUIVALENT CIRCUIT



- Notes 1.** $PW \leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$
- 2.** Mounted on ceramic substrate of $5000 \text{ mm}^2 \times 1.1 \text{ mm}$

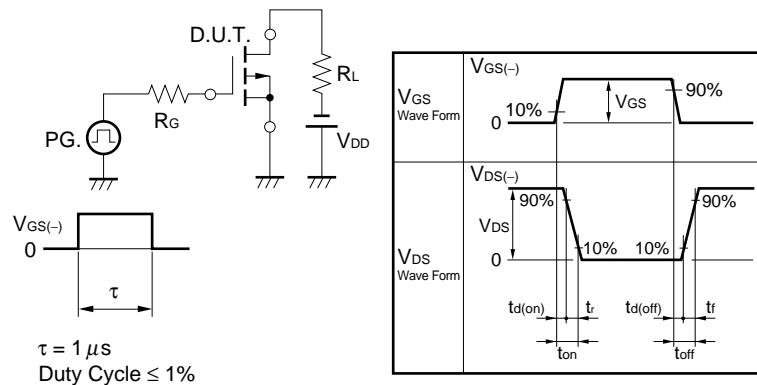
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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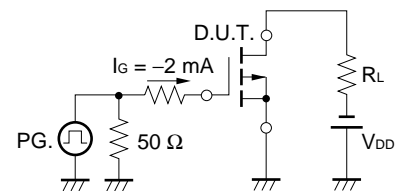
ELECTRICAL CHARACTERISTICS (TA = 25°C)

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|---------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = -30\text{ V}, V_{GS} = 0\text{ V}$ | | | -1.0 | μA |
| Gate Leakage Current | I_{GSS} | $V_{GS} = \mp 20\text{ V}, V_{DS} = 0\text{ V}$ | | | ±10 | μA |
| Gate Cut-off Voltage | $V_{GS(off)}$ | $V_{DS} = -10\text{ V}, I_D = -1.0\text{ mA}$ | -1.0 | -2.0 | -2.5 | V |
| Forward Transfer Admittance | $ y_{fs} $ | $V_{DS} = -10\text{ V}, I_D = -6.0\text{ A}$ | 11 | 23 | | S |
| Drain to Source On-state Resistance | $R_{DS(on)1}$ | $V_{GS} = -10\text{ V}, I_D = -6.0\text{ A}$ | | 9.8 | 12 | mΩ |
| | $R_{DS(on)2}$ | $V_{GS} = -4.5\text{ V}, I_D = -6.0\text{ A}$ | | 13.9 | 18.5 | mΩ |
| | $R_{DS(on)3}$ | $V_{GS} = -4.0\text{ V}, I_D = -6.0\text{ A}$ | | 16.4 | 22 | mΩ |
| Input Capacitance | C_{iss} | $V_{DS} = -10\text{ V}$ | | 2430 | | pF |
| Output Capacitance | C_{oss} | $V_{GS} = 0\text{ V}$ | | 690 | | pF |
| Reverse Transfer Capacitance | C_{rss} | $f = 1.0\text{ MHz}$ | | 420 | | pF |
| Turn-on Delay Time | $t_{d(on)}$ | $V_{DD} = -15\text{ V}, I_D = -6.0\text{ A}$ | | 19 | | ns |
| Rise Time | t_r | $V_{GS} = -10\text{ V}$ | | 17 | | ns |
| Turn-off Delay Time | $t_{d(off)}$ | $R_G = 10\ \Omega$ | | 160 | | ns |
| Fall Time | t_f | | | 160 | | ns |
| Total Gate Charge | Q_G | $V_{DD} = -24\text{ V}$ | | 45 | | nC |
| Gate to Source Charge | Q_{GS} | $V_{GS} = -10\text{ V}$ | | 5.5 | | nC |
| Gate to Drain Charge | Q_{GD} | $I_D = -12\text{ A}$ | | 15 | | nC |
| Body Diode Forward Voltage | $V_{F(S-D)}$ | $I_F = 12\text{ A}, V_{GS} = 0\text{ V}$ | | 0.83 | | V |
| Reverse Recovery Time | t_{rr} | $I_F = 12\text{ A}, V_{GS} = 0\text{ V}$ | | 50 | | ns |
| Reverse Recovery Charge | Q_{rr} | $di/dt = 100\text{ A}/\mu\text{s}$ | | 40 | | nC |

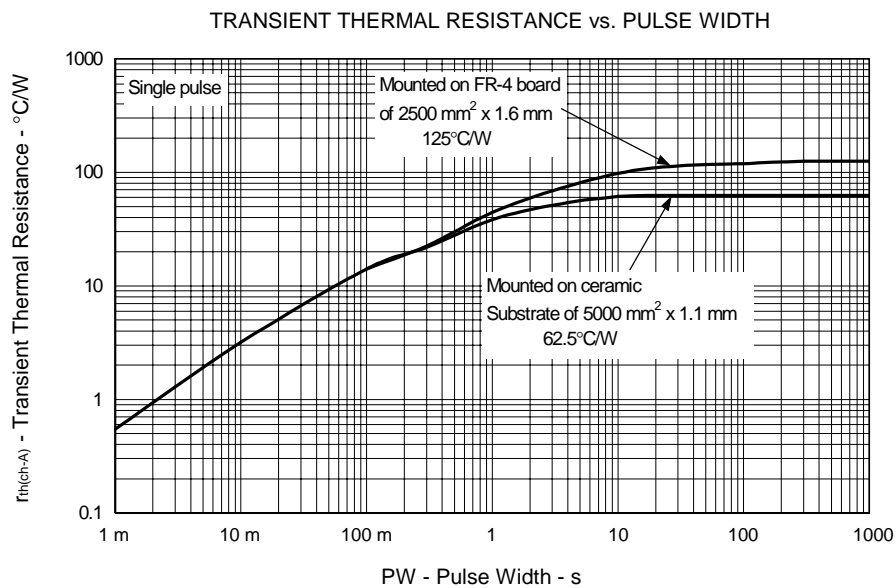
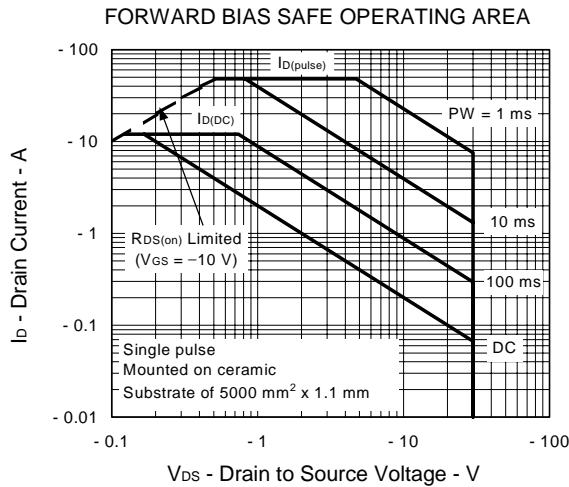
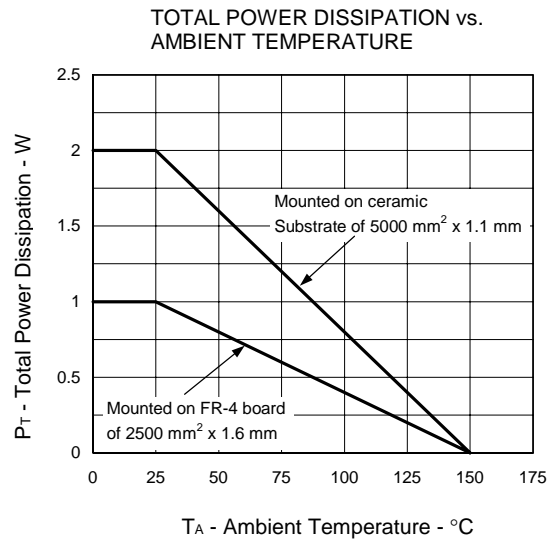
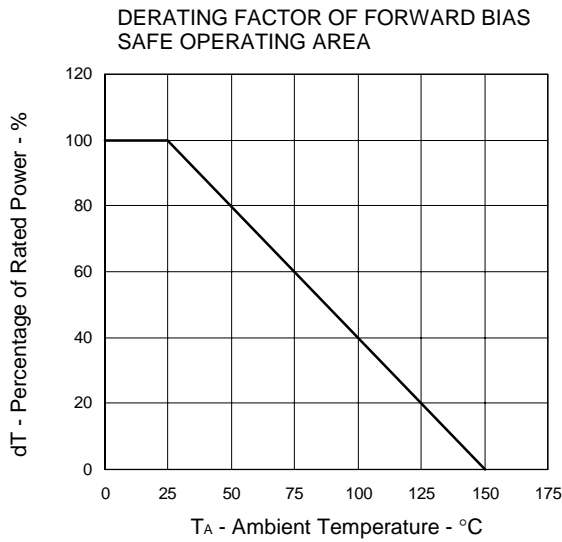
TEST CIRCUIT 1 SWITCHING TIME



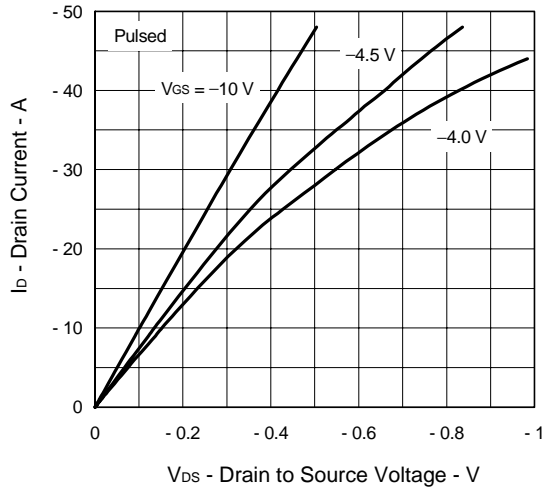
TEST CIRCUIT 2 GATE CHARGE



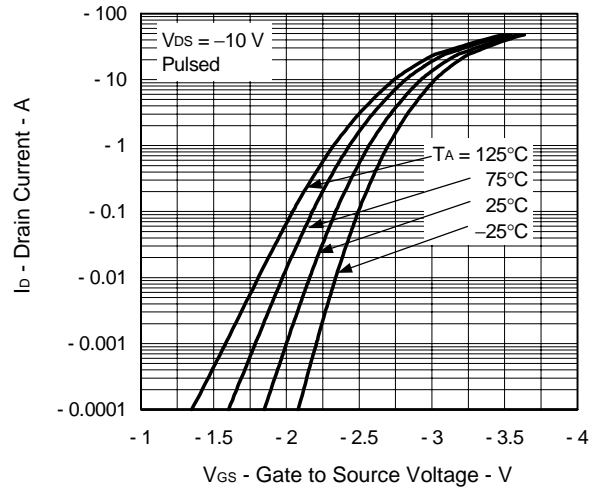
TYPICAL CHARACTERISTICS (T_A = 25°C)



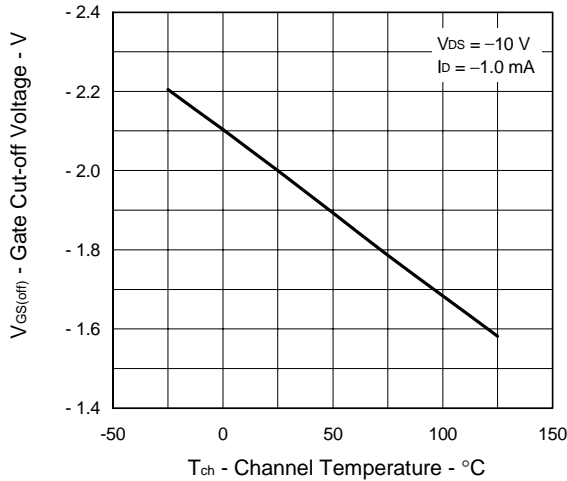
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



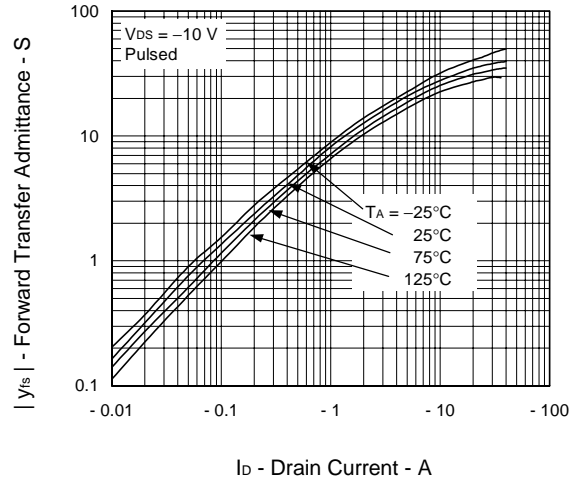
FORWARD TRANSFER CHARACTERISTICS



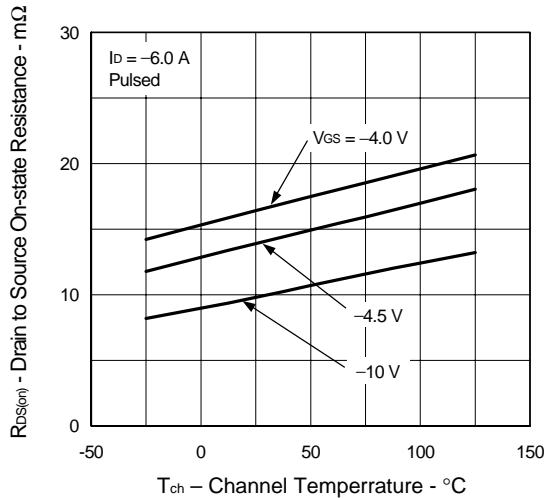
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



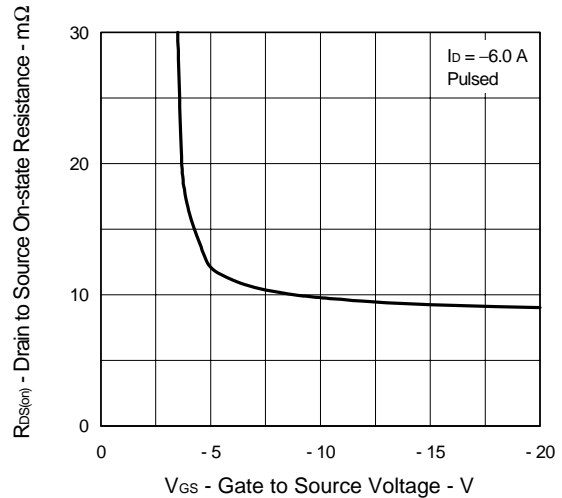
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



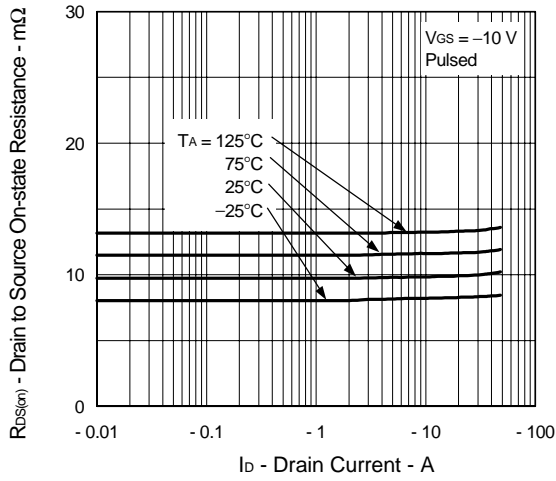
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



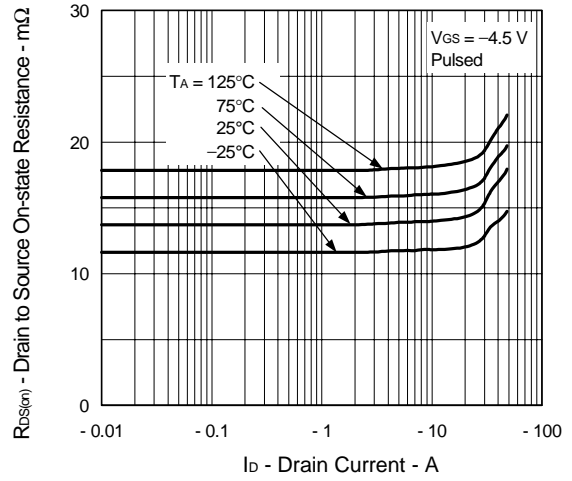
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



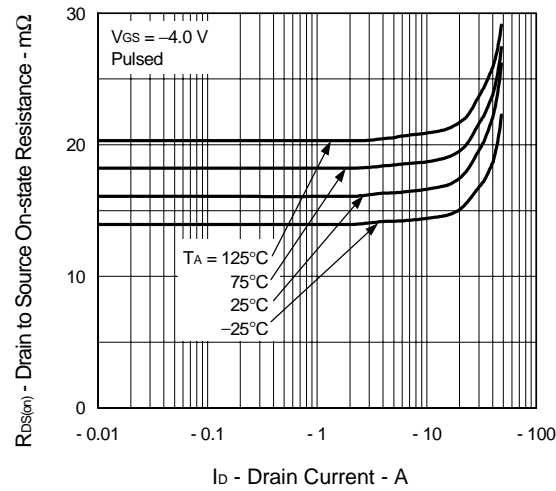
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



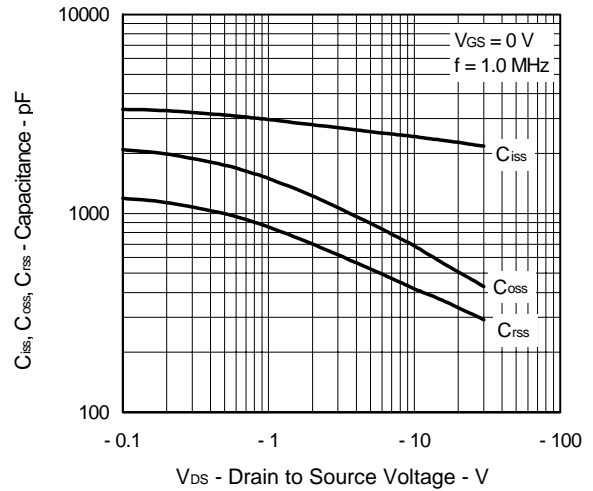
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



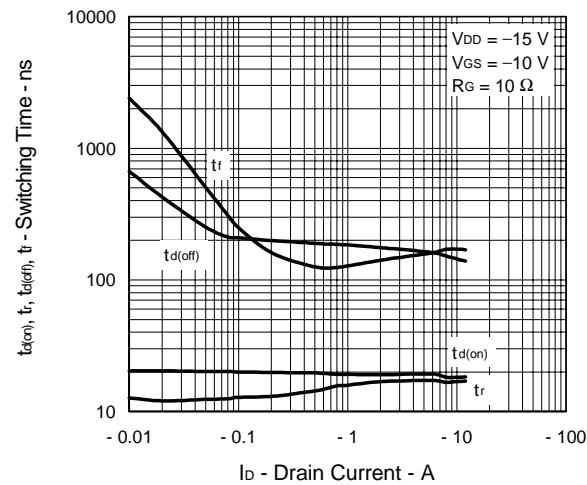
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



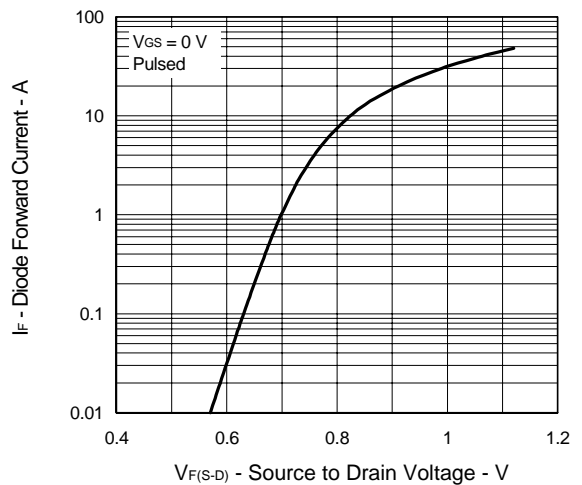
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



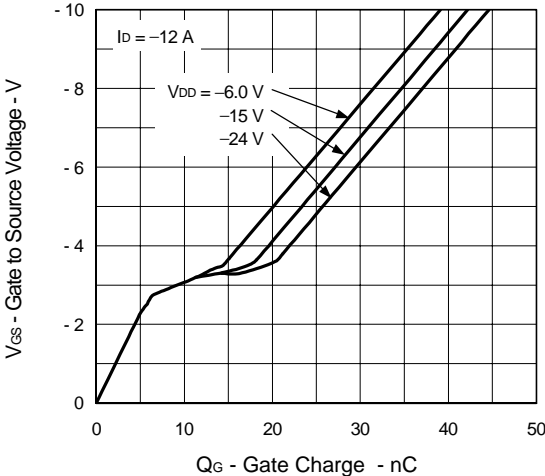
SWITCHING CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



[MEMO]

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